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 Application/Control No.	Applicant(s)/Patent under Reexamination
10/642,426	HARKONEN ET AL.
Examiner	Art Unit
B. Chen	1762

SEARCHED				
Class	Subclass	Date	Examiner	
updated	previous	11/27/2006	ВС	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
427	249.17	11/27/2006	ВС	
427	249.18	11/27/2006	ВС	
427	249.19	11/27/2006	ВС	

SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
east	11/27/2006	ВС
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